

# ZXMN2F30FH

## 20V SOT23 N-channel enhancement mode MOSFET

### Summary

| $V_{(BR)DSS}$ | $R_{DS(on)}$ ( $\Omega$ ) | $I_D$ (A) |
|---------------|---------------------------|-----------|
| 20            | 0.045 @ $V_{GS} = 4.5V$   | 4.9       |
|               | 0.065 @ $V_{GS} = 2.5V$   | 4.1       |



### Description

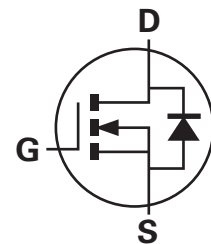
This new generation Trench MOSFET from Zetex features low on-resistance achievable with low (2.5V) gate drive.

### Features

- Low on-resistance
- 2.5V gate drive capability
- SOT23 package

### Applications

- Buck/Boost DC-DC Converters
- Load switching and SMPS
- Charging applications in portable equipment
- Motor Control
- LED Lighting

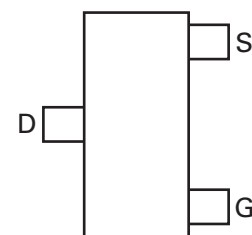


### Ordering information

| DEVICE       | Reel size (inches) | Tape width (mm) | Quantity per reel |
|--------------|--------------------|-----------------|-------------------|
| ZXMN2F30FHTA | 7                  | 8               | 3000              |

### Device marking

KNC



Top view

# ZXMN2F30FH

## Absolute maximum ratings

| Parameter  | Symbol         | Limit             | Unit        |
|--|----------------|-------------------|-------------|
| Drain source voltage   | $V_{DSS}$      | 20                | V           |
| Gate source voltage  | $V_{GS}$       | $\pm 12$          | V           |
| Continuous Drain Current @ $V_{GS}=4.5$ ; $T_A=25^\circ\text{C}^{(b)}$<br>@ $V_{GS}=4.5$ ; $T_A=70^\circ\text{C}^{(b)}$<br>@ $V_{GS}=4.5$ ; $T_A=25^\circ\text{C}^{(a)}$ | $I_D$          | 4.9<br>4.0<br>4.1 | A<br>A<br>A |
| Pulsed drain current <sup>(c)</sup>  | $I_{DM}$       | 22.6              | A           |
| Continuous source current (body diode) <sup>(b)</sup>  | $I_S$          | 1.6               | A           |
| Pulsed source current (body diode) <sup>(c)</sup>  | $I_{SM}$       | 22.6              | A           |
| Power dissipation at $T_A=25^\circ\text{C}^{(a)}$<br>Linear derating factor  | $P_D$          | 0.96<br>7.6       | W<br>mW/°C  |
| Power dissipation at $T_A=25^\circ\text{C}^{(b)}$<br>Linear derating factor  | $P_D$          | 1.4<br>11.2       | W<br>mW/°C  |
| Operating and storage temperature range  | $T_j, T_{stg}$ | -55 to 150        | °C          |

## Thermal resistance

| Parameter                          | Symbol          | Limit | Unit |
|------------------------------------|-----------------|-------|------|
| Junction to ambient <sup>(a)</sup> | $R_{\theta JA}$ | 131   | °C/W |
| Junction to ambient <sup>(b)</sup> | $R_{\theta JA}$ | 89    | °C/W |
| Junction to Lead <sup>(d)</sup>    | $R_{\theta JL}$ | 68    | °C/W |

### NOTES:

(a) For a device surface mounted on 25mm x 25mm FR4 PCB with high coverage of single sided 1oz copper, in still air conditions.

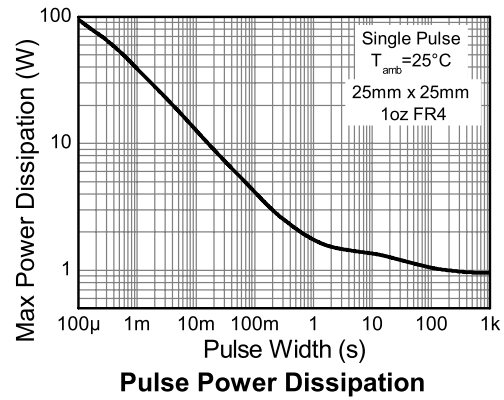
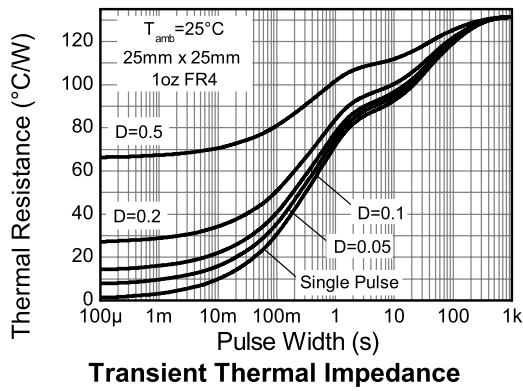
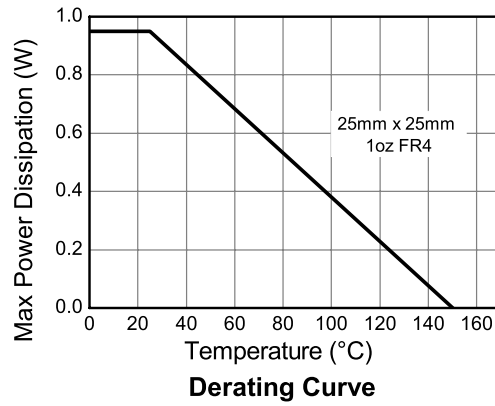
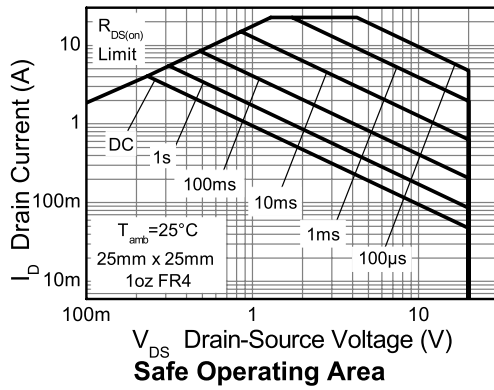
(b) For a device surface mounted on FR4 PCB measured at  $t \leq 5$  sec.

(c) Repetitive rating - 25mm x 25mm FR4 PCB,  $D=0.02$ , pulse width 300 $\mu\text{s}$  - pulse width limited by maximum junction temperature.

(d) Thermal resistance from junction to solder-point (at the end of the drain lead).

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## Thermal characteristics



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## Electrical characteristics (at $T_{amb} = 25^{\circ}\text{C}$ unless otherwise stated)

| Parameter                                   | Symbol        | Min. | Typ. | Max.           | Unit                 | Conditions   |
|---|---------------|------|------|----------------|----------------------|--|
| <b>Static</b>                               |               |      |      |                |                      |  |
| Drain-Source Breakdown Voltage              | $V_{(BR)DSS}$ | 20   |      |                | V                    | $I_D = 250\mu\text{A}$ , $V_{GS} = 0\text{V}$  |
| Zero Gate Voltage Drain Current             | $I_{DSS}$     |      |      | 1              | $\mu\text{A}$        | $V_{DS} = 20\text{V}$ , $V_{GS} = 0\text{V}$   |
| Gate-Body Leakage                           | $I_{GSS}$     |      |      | 100            | nA                   | $V_{GS} = \pm 12\text{V}$ , $V_{DS} = 0\text{V}$   |
| Gate-Source Threshold Voltage               | $V_{GS(th)}$  | 0.6  | 0.9  | 1.5            | V                    | $I_D = 250\mu\text{A}$ , $V_{DS} = V_{GS}$   |
| Static Drain-Source On-State Resistance (*) | $R_{DS(on)}$  |      |      | 0.045<br>0.065 | $\Omega$<br>$\Omega$ | $V_{GS} = 4.5\text{V}$ , $I_D = 2.5\text{A}$<br>$V_{GS} = 2.5\text{V}$ , $I_D = 2.0\text{A}$   |
| Forward Transconductance <sup>(*)(†)</sup>  | $g_{fs}$      |      | 8.6  |                | S                    | $V_{DS} = 10\text{V}$ , $I_D = 3\text{A}$  |
| <b>Dynamic (†)</b>                          |               |      |      |                |                      |  |
| Input Capacitance                           | $C_{iss}$     |      | 452  |                | pF                   | $V_{DS} = 10\text{V}$ , $V_{GS} = 0\text{V}$<br>$f = 1\text{MHz}$                              |
| Output Capacitance                          | $C_{oss}$     |      | 102  |                | pF                   |  |
| Reverse Transfer Capacitance                | $C_{rss}$     |      | 58   |                | pF                   |  |
| <b>Switching (‡)(†)</b>                     |               |      |      |                |                      |  |
| Turn-On-Delay Time                          | $t_{d(on)}$   |      | 2.9  |                | ns                   | $V_{DD} = 10\text{V}$ , $V_{GS} = 4.5\text{V}$<br>$I_D = 1\text{A}$<br>$R_G \approx 6.0\Omega$ |
| Rise Time                                   | $t_r$         |      | 5.6  |                | ns                   |  |
| Turn-Off Delay Time                         | $t_{d(off)}$  |      | 19.4 |                | ns                   |  |
| Fall Time                                   | $t_f$         |      | 10.2 |                | ns                   |  |
| Total Gate Charge                           | $Q_g$         |      | 4.8  |                | nC                   | $V_{DS} = 10\text{V}$ , $V_{GS} = 4.5\text{V}$<br>$I_D = 3.5\text{A}$                          |
| Gate-Source Charge                          | $Q_{gs}$      |      | 1    |                | nC                   |  |
| Gate Drain Charge                           | $Q_{gd}$      |      | 1.2  |                | nC                   |  |
| <b>Source-drain diode</b>                   |               |      |      |                |                      |  |
| Diode Forward Voltage <sup>(*)</sup>        | $V_{SD}$      |      | 0.75 | 1.2            | V                    | $I_S = 1.25\text{A}$ , $V_{GS} = 0\text{V}$  |

### NOTES:

(\*) Measured under pulsed conditions. Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

(†) For design aid only, not subject to production testing.

(‡) Switching characteristics are independent of operating junction temperature.

## Typical characteristics

Fig1.  $I_D - V_{DS}$

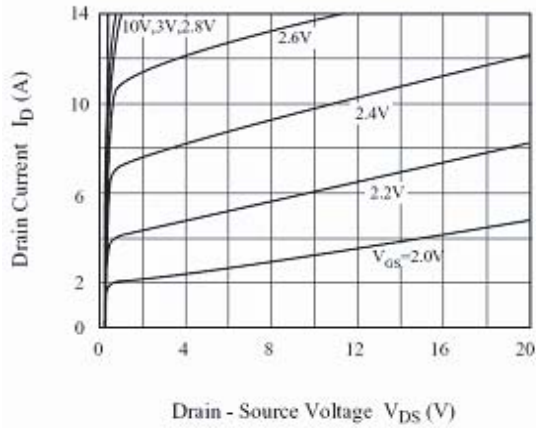


Fig2.  $R_{DS(on)} - I_D$

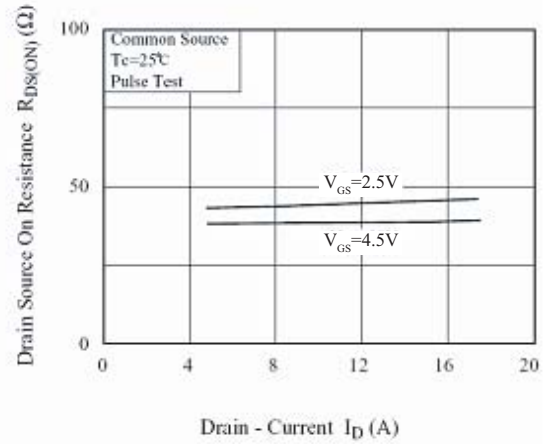


Fig3.  $I_D - V_{GS}$

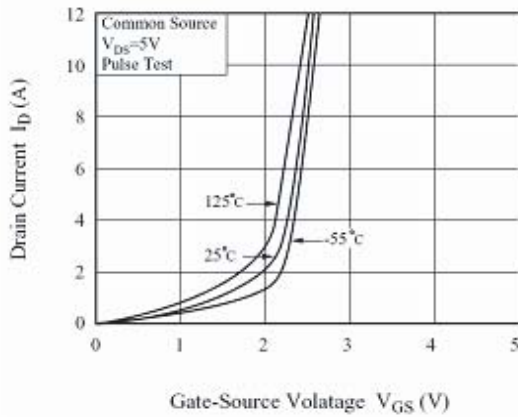


Fig4.  $R_{DS(on)} - T_J$

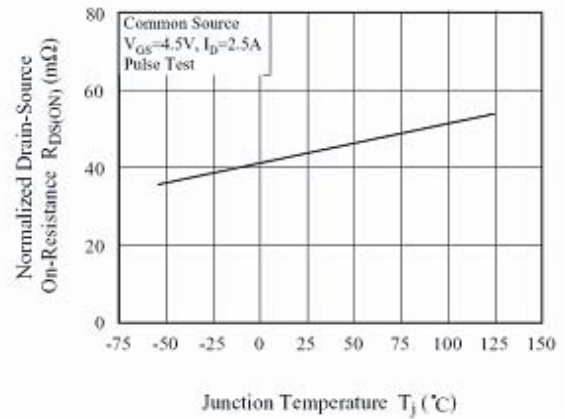


Fig5.  $V_{th} - T_J$

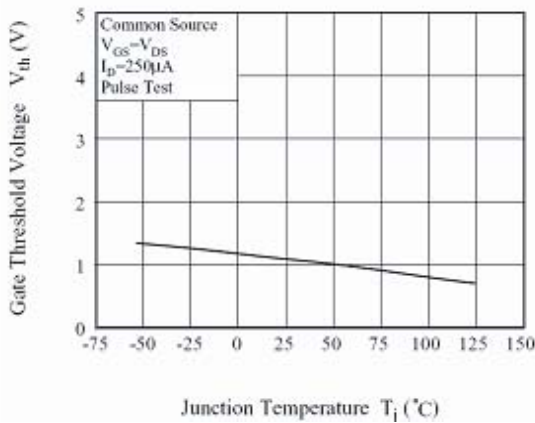
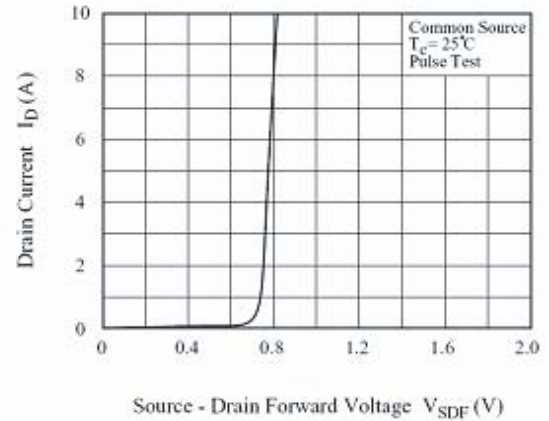
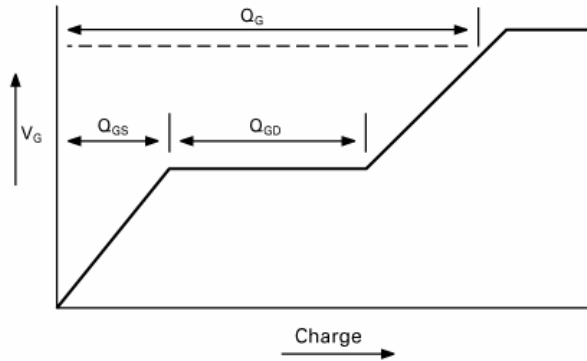


Fig6.  $I_S - V_{SDF}$

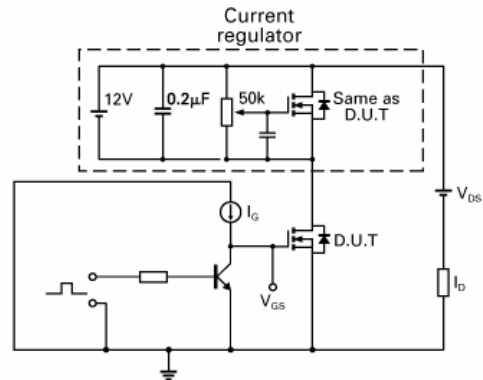


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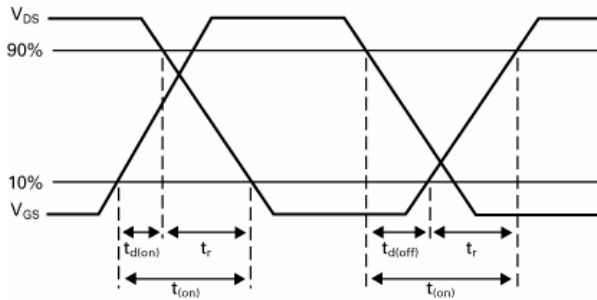
## Test circuits



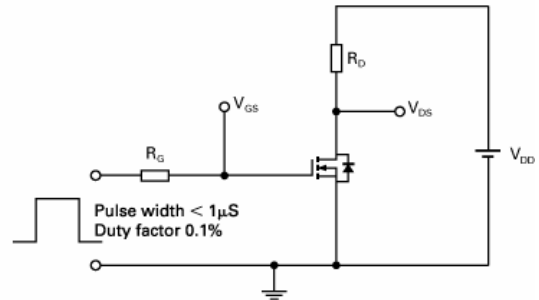
**Basic gate charge waveform**



**Gate charge test circuit**



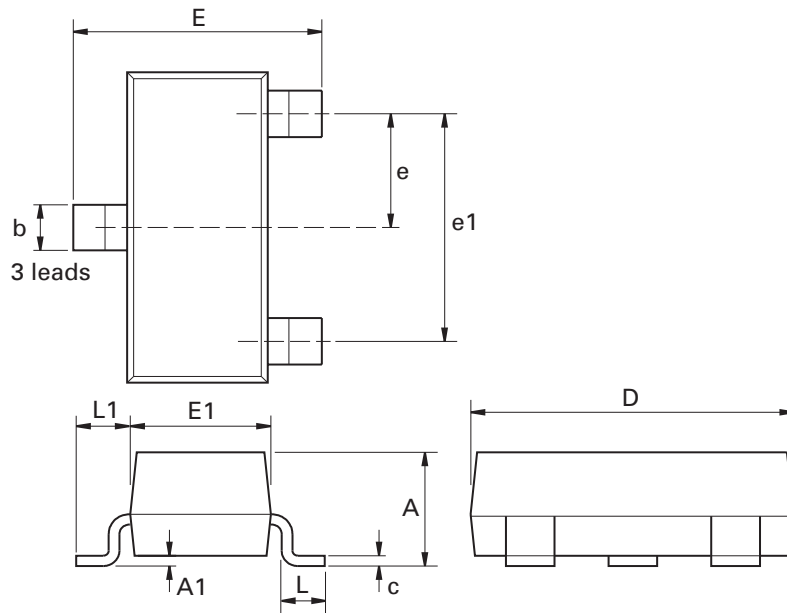
**Switching time waveforms**



**Switching time test circuit**

# ZXMN2F30FH

## Package outline - SOT23



| Dim. | Millimeters |      | Inches    |       | Dim. | Millimeters |      | Inches    |        |
|------|-------------|------|-----------|-------|------|-------------|------|-----------|--------|
|      | Min.        | Max. | Min.      | Max.  |      | Min.        | Max. | Min.      | Max.   |
| A    | -           | 1.12 | -         | 0.044 | e1   | 1.90 NOM    |      | 0.075 NOM |        |
| A1   | 0.01        | 0.10 | 0.0004    | 0.004 | E    | 2.10        | 2.64 | 0.083     | 0.104  |
| b    | 0.30        | 0.50 | 0.012     | 0.020 | E1   | 1.20        | 1.40 | 0.047     | 0.055  |
| c    | 0.085       | 0.20 | 0.003     | 0.008 | L    | 0.25        | 0.60 | 0.0098    | 0.0236 |
| D    | 2.80        | 3.04 | 0.110     | 0.120 | L1   | 0.45        | 0.62 | 0.018     | 0.024  |
| e    | 0.95 NOM    |      | 0.037 NOM |       | -    | -           | -    | -         | -      |

**Note:** Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

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| "Active"                          | Product status recommended for new designs                                     |
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|                       |   |
|-----------------------|---|
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